

## **Patent and Trademark Office**

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APPLICATION NO.	FILING DATE	FIRST NAMED I	NVENTOR		ATTORNEY DOCKET NO.
09/262,781	03/04/99	SINGER		N	01620895-001
CHOATE HALL & STEWART EXCHANGE PLACE 53 STATE STREET BOSTON MA 02109-2891		TM21/0404	¬		EXAMINER
				CAO,C	
				ART UNIT	PAPER NUMBER
				2182	17
				DATE MAILED:	04/04/01

Please find below and/or attached an Office communication concerning this application or proceeding.

**Commissioner of Patents and Trademarks** 



## UNITED STATES DEPARTMENT OF COMMERCE Patent and Trademark Office

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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	
_		7,	EXAMINER	
			ART UNIT PAPER NUMBER	
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DATE MAILED:

## Notice of Non-Compliant Amendment (37 CFR 1.121)

format r	The amendment filed on 4-2-0/ is considered non-compliant because it has not been submitted in the required under 37 CFR 1.121, as amended on September 8, 2000 (see 65 Fed. Reg. 54603, Sept. 8, 2000 and 1238 O.G. t. 19, 2000).
77, BCp	17, 2000 <i>).</i>
	The amendment does not include a clean version of the replacement paragraph/section. 37 CFR 1.121(b)(1)(ii)
	The amendment does not include a marked-up version of the replacement paragraph/section 37 CFR 1.121(b)(1)(iii)
囡	The amendment does not include a clean version of the amended claim(s). 37 CFR 1.121(c)(1)(i)
区	The amendment does not include a marked-up version of the amended claim(s). 37 CFR 1.121(c)(1)(ii)
flver (	For your convenience, attached to this correspondence is a copy of an informational MPEP Bookmark Bulletin on "Simplified Amendment Practice")

Applicant is given a TIME PERIOD of ONE (1) MONTH or THIRTY (30) DAYS from the mailing date of this notice, whichever is longer, within which to submit an amendment in compliance with 37 CFR 1.121, effective March 1, 2001, in order to avoid abandonment. EXTENSIONS OF THIS TIME PERIOD MAY BE GRANTED UNDER 37 C.F.R. 1.136(a).

Legal Instruments Examiner